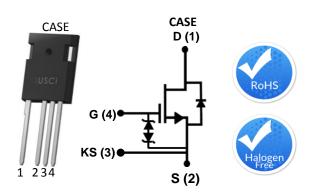
Datasheet

Description

United Silicon Carbide's cascode products co-package its high-performance F3 SiC fast JFETs with a cascode optimized MOSFET to produce the only standard gate drive SiC device in the market today. This series exhibits very fast switching using a 4-terminal TO-247-package and the best reverse recovery characteristics of any device of similar ratings. These devices are excellent for switching inductive loads, and any application requiring standard gate drive.



Part Number	Package	Marking				
UF3C065030K4S	TO-247-4L	UF3C065030K4S				

Features

- Typical on-resistance R_{DS(on),typ} of 30mΩ
- Maximum operating temperature of 175°C
- Excellent reverse recovery
- Low gate charge
- Low intrinsic capacitance
- ESD protected, HBM class 2
- TO-247-4L package for faster switching, clean gate waveforms

Typical Applications

- EV charging
- PV inverters
- Switch mode power supplies
- Power factor correction modules
- Motor drives
- Induction heating

Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	V _{DS}		650	V
Gate-source voltage	V _{GS}	DC	-25 to +25	V
Continuous drain current ¹	I _D	T _C =25°C	85	Α
Continuous arain current		T _C =100°C	62	А
Pulsed drain current ²	I _{DM}	T _C =25°C	230	А
Single pulsed avalanche energy ³	E _{AS}	L=15mH, I _{AS} =4A	120	mJ
Power dissipation	P _{tot}	T _C =25°C	441	W
Maximum junction temperature	T _{J,max}		175	°C
Operating and storage temperature	T _J , T _{STG}		-55 to 175	°C
Max. lead temperature for soldering, 1/8" from case for 5 seconds	TL		250	°C

- 1 Limited by T_{I max}
- 2 Pulse width t_p limited by T_{J,max}
- 3 Starting T₁ = 25°C

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Electrical Characteristics (T_J = +25°C unless otherwise specified)

Typical Performance - Static

Davamatav	Symbol	Test Conditions	Value			Heite
Parameter			Min	Тур	Max	Units
Drain-source breakdown voltage	BV _{DS}	V _{GS} =0V, I _D =1mA	650			V
Takal duala la la la anno anno a	I _{DSS}	V _{DS} =650V, V _{GS} =0V, T _J =25°C		6	150	- μΑ
Total drain leakage current		V _{DS} =650V, V _{GS} =0V, T _J =175°C		30		
Total gate leakage current	I _{GSS}	V _{DS} =0V, T _j =25°C, V _{GS} =-20V / +20V		6	± 20	μΑ
Drain source on recistance	R _{DS(on)}	V _{GS} =12V, I _D =50A, T _J =25°C		30	35	- mΩ
Drain-source on-resistance		V _{GS} =12V, I _D =50A, T _J =175°C		48		
Gate threshold voltage	V _{G(th)}	V _{DS} =5V, I _D =10mA	4	5	6	V
Gate resistance	R_{G}	f=1MHz, open drain		4.5		Ω

Typical Performance - Reverse Diode

Davamatar	Symbol	Test Conditions	Value			l luite
Parameter			Min	Тур	Max	Units
Diode continuous forward current ¹	I _s	T _C =25°C			85	А
Diode pulse current ²	I _{S,pulse}	T _C =25°C			230	А
Forward voltage	V _{FSD}	V _{GS} =0V, I _F =20A, T _J =25°C		1.3	1.4	- V
roi waru voitage		V _{GS} =0V, I _F =20A, T _J =175°C		1.35		
Reverse recovery charge	Q _{rr}	V_R =400V, I_F =50A, V_{GS} =-5V, R_{G_EXT} =10 Ω		425		nC
Reverse recovery time	t _{rr}	di/dt=2650A/μs, Τ _J =25°C		25		ns
Reverse recovery charge	Q _{rr}	V_R =400V, I_F =50A, V_{GS} =-5V, R_{G_EXT} =10 Ω		280		nC
Reverse recovery time	t _{rr}	di/dt=2650A/μs, Τ _J =150°C		20		ns



Typical Performance - Dynamic

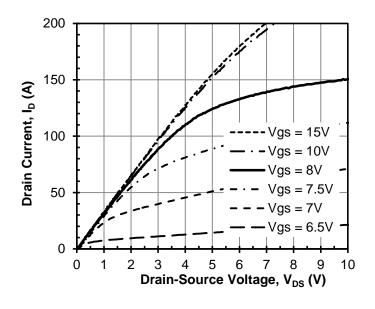
Parameter	symbol	Test Conditions	Value			Units
			Min	Тур	Max	Units
Input capacitance	C _{iss}	V _{DS} =100V,		1500		pF
Output capacitance	C _{oss}	V _{GS} =0V,		320		
Reverse transfer capacitance	C _{rss}	f=100kHz		2.3		
Effective output capacitance, energy related	C _{oss(er)}	V _{DS} =0V to 400V, V _{GS} =0V		230		pF
Effective output capacitance, time related	C _{oss(tr)}	V _{DS} =0V to 400V, V _{GS} =0V		520		pF
C _{oss} stored energy	E _{oss}	V _{DS} =400V, V _{GS} =0V		18.5		μJ
Total gate charge	Q_{G}	V _{DS} =400V, I _D =50A, V _{GS} =-5V to 15V		51		nC
Gate-drain charge	Q _{GD}			11		
Gate-source charge	Q_{GS}			19		
Turn-on delay time	t _{d(on)}	V_{DS} =400V, I_{D} =50A, Gate Driver=-5V to +12V, Turn-on $R_{G,EXT}$ =8.5 Ω , Turn-off $R_{G,EXT}$ =20 Ω Inductive Load, FWD: same device with		25		ns µJ
Rise time	t _r			31		
Turn-off delay time	t _{d(off)}			48		
Fall time	t _f			12		
Turn-on energy	E _{ON}			310		
Turn-off energy	E _{OFF}	V_{GS} = -5V, R_{G} = 10Ω		171		
Total switching energy	E _{TOTAL}	T _J =25°C		481		
Turn-on delay time	t _{d(on)}	V _{DS} =400V, I _D =50A, Gate		22		
Rise time	t _r	Driver=-5V to +12V,		27		ns
Turn-off delay time	t _{d(off)}	Turn-on $R_{G,EXT}$ =8.5 Ω , Turn-off $R_{G,EXT}$ =20 Ω Inductive Load,		48		
Fall time	t _f			10		
Turn-on energy	E _{ON}	FWD: same device with		247		μ
Turn-off energy	E _{OFF}	V_{GS} = -5V, R_{G} = 10Ω		114		
Total switching energy	E _{TOTAL}	T _J =150°C	<u> </u>	361		

Thermal Characteristics

Parameter	symbol	Test Conditions	Value			Units
			Min	Тур	Max	Units
Thermal resistance, junction-to-case	$R_{\theta JC}$			0.26	0.34	°C/W



Typical Performance Diagrams



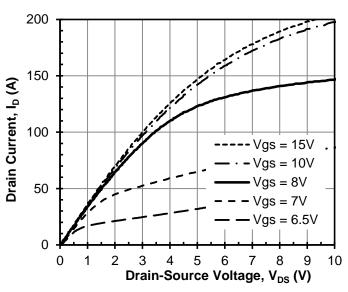


Figure 1 Typical output characteristics at $T_J = -55$ °C, $tp < 250 \mu s$

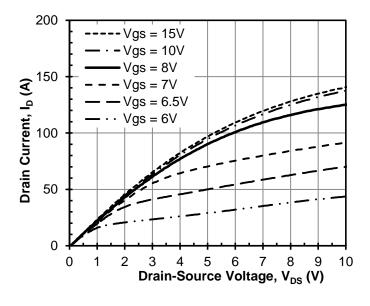


Figure 3 Typical output characteristics

at $T_J = 175$ °C, $tp < 250 \mu$ s

Figure 2 Typical output characteristics at $T_J = 25$ °C, $tp < 250 \mu s$

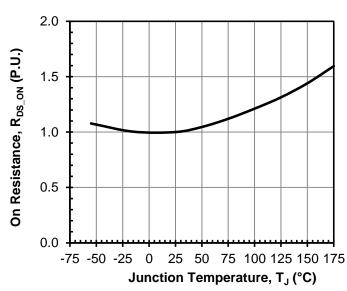


Figure 4 Normalized on-resistance vs. temperature at $V_{GS} = 12V$ and $I_D = 50A$

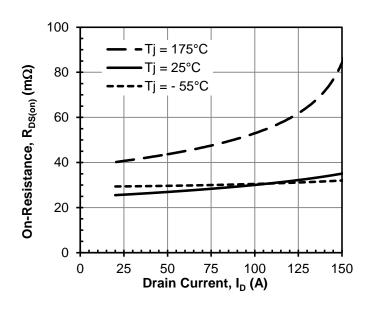


Figure 5 Typical drain-source on-resistance at $V_{GS} = 12V$

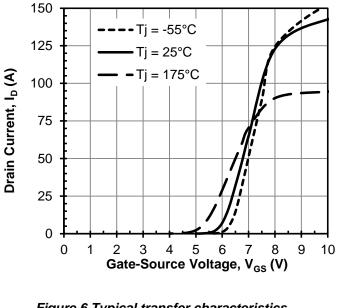


Figure 6 Typical transfer characteristics at $V_{DS} = 5V$

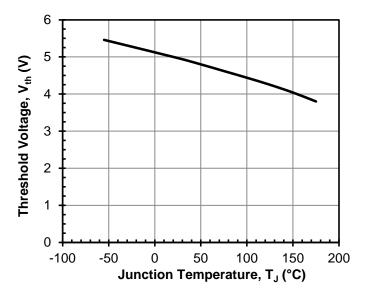


Figure 7 Threshold voltage vs. T J at $V_{DS} = 5V$ and $I_D = 10mA$

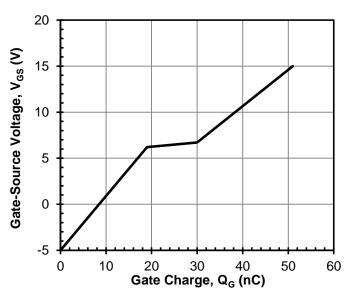
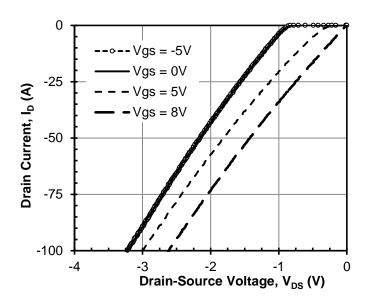


Figure 8 Typical gate charge at $V_{DS} = 400V$ and $I_D = 50A$

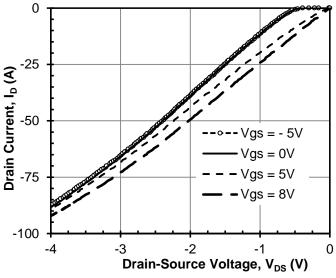


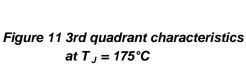


-- Vgs = - 5V Vgs = 0V-25 Vgs = 5VDrain Current, I_D (A) • Vgs = 8V -50 -75 -100 -2 Drain-Source Voltage, V_{DS} (V)

Figure 9 3rd quadrant characteristics at $T_J = -55$ °C

Figure 10 3rd quadrant characteristics at $T_J = 25$ °C





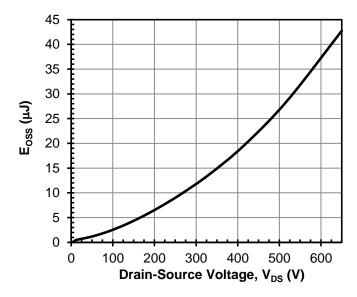
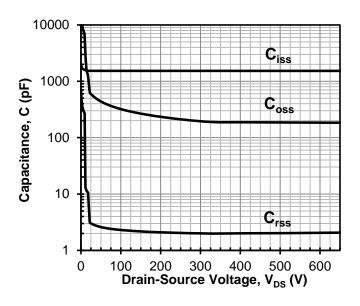


Figure 12 Typical stored energy in Coss at $V_{GS} = 0V$





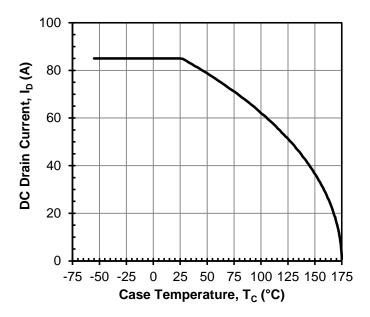


Figure 13 Typical capacitances at 100kHz and $V_{GS} = 0V$

Figure 14 DC drain current derating

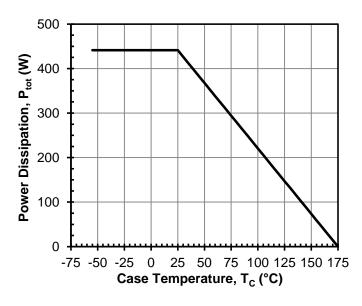


Figure 15 Total power dissipation

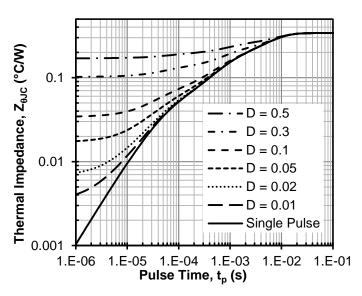


Figure 16 Maximum transient thermal impedance



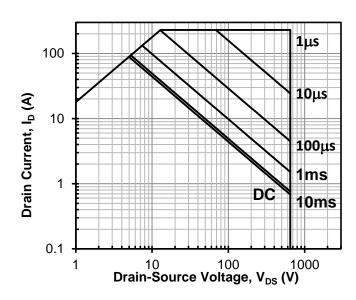


Figure 17 Safe operation area $T_c = 25$ °C, D = 0, Parameter t_p

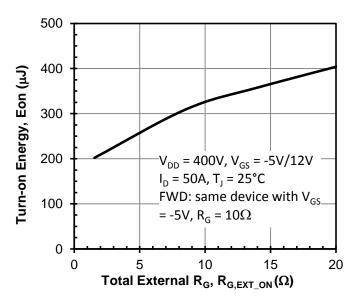


Figure 19 Clamped inductive switching turn-on energy vs. R G.EXT ON

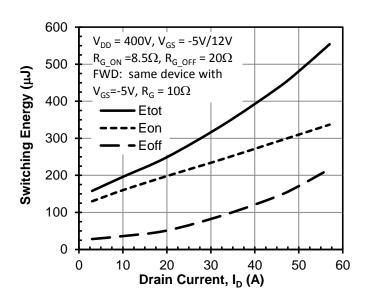


Figure 18 Clamped inductive switching energy vs. drain current at $T_J = 25$ °C

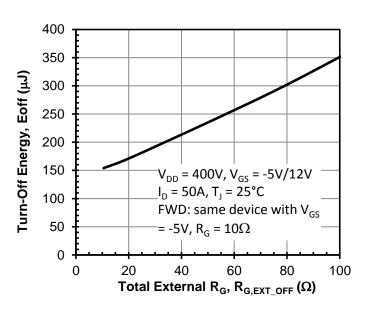


Figure 20 Clamped inductive switching turn-off energy vs. R G.EXT OFF

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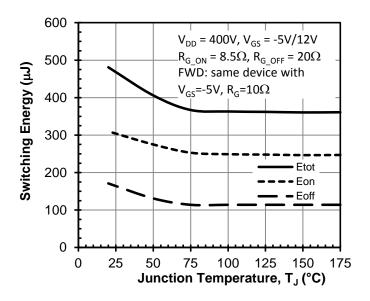


Figure 21 Clamped inductive switching energy vs. junction temperature at $I_D = 50A$

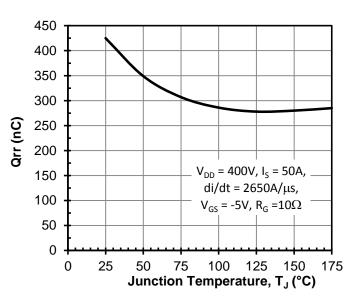


Figure 22 Reverse recovery charge Qrr vs. junction temperture

Applications Information

SiC cascodes are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance (R_{DS(on)}), output capacitance (Coss), gate charge (Qg), and reverse recovery charge (Qrr) leading to low conduction and switching losses. The SiC cascodes also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the cascode is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on cascode operation, see www.unitedsic.com.

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